Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/087,437	LAIHO ET AL.
Examiner	Art Unit
Tu X. Nauven	2684

SEARCHED				
Class	Subclass	Date	Examiner	
455	406	2/1/2006	TN	
	424			
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	67.1			
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	555			
	461			
340	3111.1			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search East	2/1/2006	TN	